Unit: mm

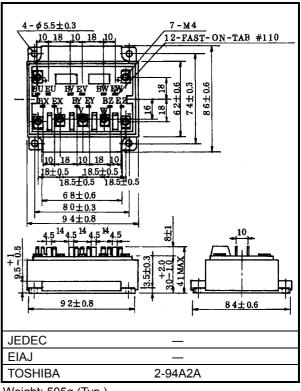
TOSHIBA GTR Module Silicon N Channel IGBT

# MG100J6ES50

### **High Power Switching Applications Motor Control Applications**

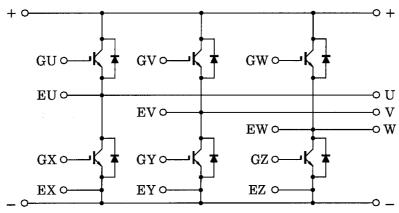
- The electrodes are isolated from case.
- High input impedance.
- 6 IGBTs built into 1 package.
- Enhancement-mode.
- High speed:  $t_f = 0.30 \mu s \text{ (Max) (IC} = 100 \text{A)}$  $t_{rr} = 0.15 \mu s \text{ (Max) (IF} = 100 \text{A)}$
- Low saturation voltage

 $: V_{CE (sat)} = 2.70 V (Max) (I_{C} = 100 A)$ 



#### Weight: 505g (Typ.)

## **Equivalent Circuit**



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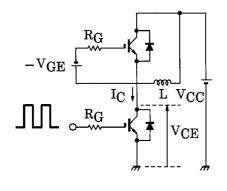
## Maximum Ratings (Ta = 25°C)

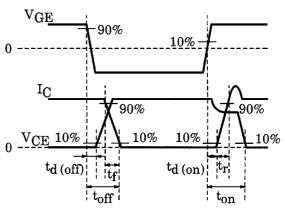
Characteristic		Symbol	Rating	Unit	
Collector-emitter voltage		V <sub>CES</sub>	600	V	
Gate-emitter voltage		V <sub>GES</sub>	±20	V	
Collector current	DC	IC	100	А	
	1ms	I <sub>CP</sub>	200		
Forward current	DC	l <sub>F</sub>	100	А	
	1ms	I <sub>FM</sub>	200		
Collector power dissipation (Tc=25°C)		PC	450	W	
Junction temperature		Tj	150	°C	
Storage temperature range		T <sub>stg</sub>	<b>−</b> 40 ~ 125	°C	
Isolation voltage		V <sub>Isol</sub>	2500 (AC 1 min.)	V	
Screw torque (Terminal / mounting)		_	2/3	N·m	

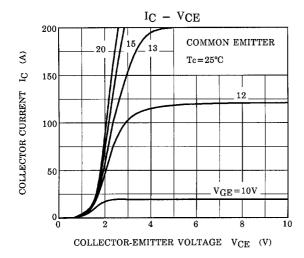
#### **Electrical Characteristics (Ta = 25°C)**

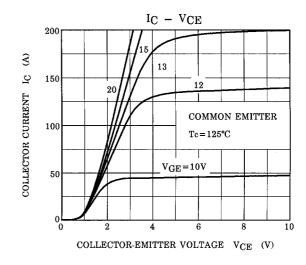
C	Characteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I <sub>GES</sub>	V <sub>GE</sub> = ±20V, V <sub>CE</sub> = 0	_	_	±500	nA
Collector cut-off current		I <sub>CES</sub>	V <sub>CE</sub> = 600V, V <sub>GE</sub> = 0	_	_	1.0	mA
Gate-emitter cut-off voltage		V <sub>GE (off)</sub>	I <sub>C</sub> = 10mA, V <sub>CE</sub> = 5V	5.0	7.0	8.0	V
Collector-emitter saturation voltage		V <sub>CE</sub> (sat)	I <sub>C</sub> = 100A, V <sub>GE</sub> = 15V	_	2.10	2.70	V
Input capacitan	ce	C <sub>ies</sub>	V <sub>CE</sub> = 10V, V <sub>GE</sub> = 0, f = 1MHz	_	9000	_	pF
Switching time	Turn-on delay time	t <sub>d (on)</sub>	Inductive load $V_{CC} = 300V$ $I_{C} = 100A$ $V_{GE} = \pm 15V$ $R_{G} = 13\Omega$ (Note 1)	_	0.08	0.16	μs
	Rise time	t <sub>r</sub>		_	0.12	0.24	
	Turn-on time	t <sub>on</sub>		_	0.40	0.80	
	Turn-off delay time	t <sub>d (off)</sub>		_	0.20	0.40	
	Fall time	t <sub>f</sub>		-	0.15	0.30	
	Turn-off time	t <sub>off</sub>		-	0.50	1.00	
Forward voltage	9	V <sub>F</sub>	I <sub>F</sub> = 100A, V <sub>GE</sub> = 0	_	2.30	3.00	V
Reverse recovery time		t <sub>rr</sub>	I <sub>F</sub> = 100A, V <sub>GE</sub> = -10V di / dt = 100A / μs	_	0.08	0.15	μs
Thermal resistance		R <sub>th (j-c)</sub>	Transistor	_	_	0.28	°C/W
			Diode	_		0.69	

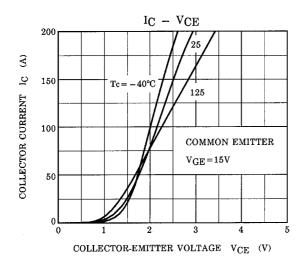
Note 1: Switching time test circuit & timing chert

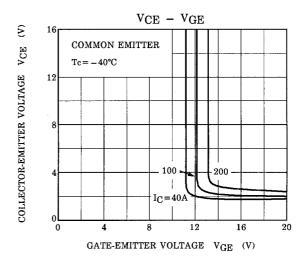


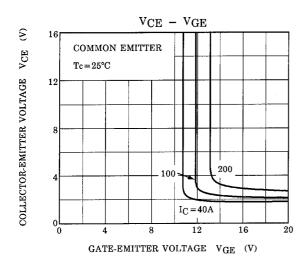


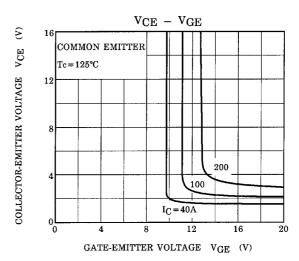


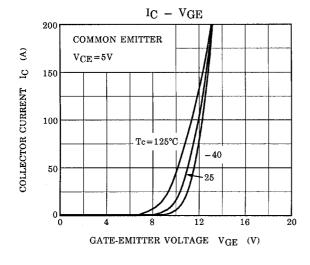


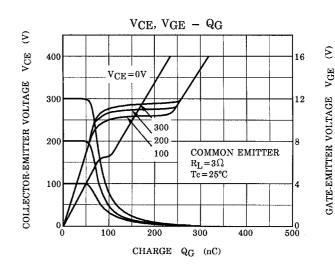


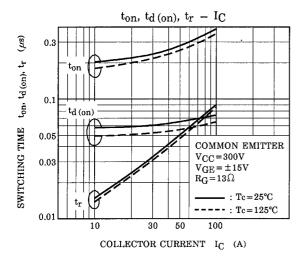


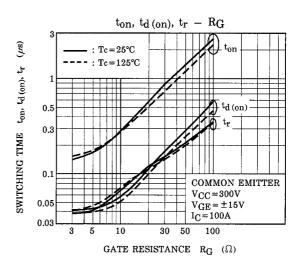


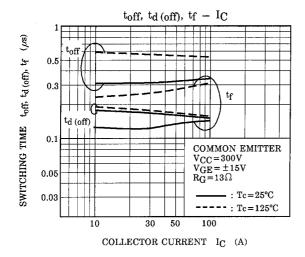


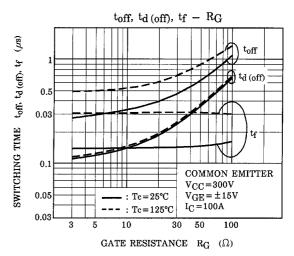


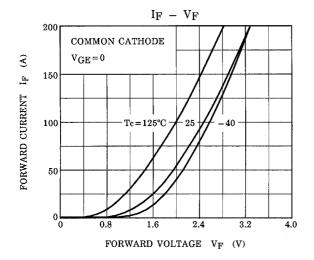


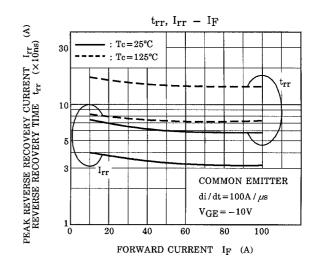


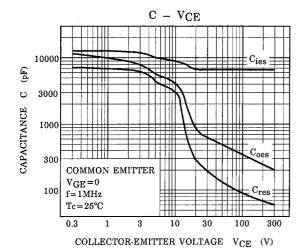


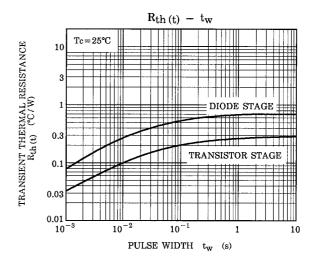


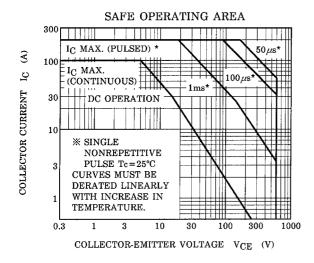


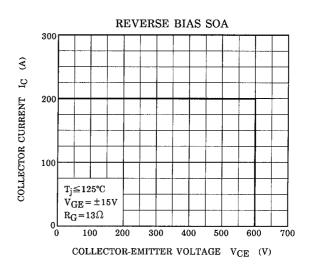












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